

**ON Semiconductor®** 

J111 / J112 / J113 / MMBFJ111 / MMBFJ112 / MMBFJ113 N-Channel Switch

### Features

- This device is designed for low level analog switching, sample and hold circuits and chopper stabilized amplifiers.
- Sourced from process 51
- Source & Drain are interchangeable.



Figure 1. J111 / J112 / J113 Device Package

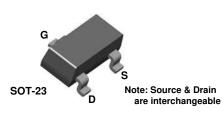


Figure 2. MMBFJ111 / MMBFJ112 / MMBFJ113 Device Package

| Part Number | Top Mark | Package   | Packing Method |
|-------------|----------|-----------|----------------|
| J111        | J111     | TO-92 3L  | Bulk           |
| J111-D26Z   | J111     | TO-92 3L  | Tape and Reel  |
| J111-D74Z   | J111     | TO-92 3L  | Ammo           |
| J112        | J112     | TO-92 3L  | Bulk           |
| J112-D26Z   | J112     | TO-92 3L  | Tape and Reel  |
| J112-D27Z   | J112     | TO-92 3L  | Tape and Reel  |
| J112-D74Z   | J112     | TO-92 3L  | Ammo           |
| J113        | J113     | TO-92 3L  | Bulk           |
| J113-D74Z   | J113     | TO-92 3L  | Ammo           |
| J113-D75Z   | J113     | TO-92 3L  | Ammo           |
| MMBFJ111    | 6P       | SOT-23 3L | Tape and Reel  |
| MMBFJ112    | 6R       | SOT-23 3L | Tape and Reel  |
| MMBFJ113    | 6S       | SOT-23 3L | Tape and Reel  |

## **Ordering Information**

# Absolute Maximum Ratings(1), (2)

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only. Values are at  $T_A = 25^{\circ}C$  unless otherwise noted.

| Symbol                            | Parameter  | Value      | Unit |
|-----------------------------------|--|------------|------|
| V <sub>DG</sub>                   | Drain-Gate Voltage                               | 35         | V    |
| V <sub>GS</sub>                   | Gate-Source Voltage                              | -35        | V    |
| I <sub>GF</sub>                   | Forward Gate Current                             | 50         | mA   |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperature Range | -55 to 150 | °C   |

### Notes:

- 1. These ratings are based on a maximum junction temperature of 150°C.
- 2. These are steady-state limits. ON Semiconductor should be consulted on applications involving pulsed or lowduty-cycle operations.

## **Thermal Characteristics**

Values are at  $T_A = 25^{\circ}C$  unless otherwise noted.

|                       |   | Ма                                   |   |       |
|-----------------------|---|--------------------------------------|---|-------|
| Symbol                | Parameter                               | J111 / J112 /<br>J113 <sup>(3)</sup> | MMBFJ111 /<br>MMBFJ112 /<br>MMBFJ113 <sup>(4)</sup> | Unit  |
| Р                     | Total Device Dissipation                | 625                                  | 350   | mW    |
| P <sub>D</sub>        | Derate Above 25°C                       | 5.0                                  | 2.8   | mW/°C |
| R <sub>θJC</sub>      | Thermal Resistance, Junction-to-Case    | 125                                  |   | °C/W  |
| $R_{	extsf{	heta}JA}$ | Thermal Resistance, Junction-to-Ambient | 200                                  | 357   | °C/W  |

### Notes:

3. PCB size: FR-4, 76 mm x 114 mm x 1.57 mm (3.0 inch x 4.5 inch x 0.062 inch) with minimum land pattern size.

4. Device mounted on FR-4 PCB 36mm  $\times$  18mm  $\times$  1.5mm; mounting pad for the collector lead minimum 6cm<sup>2</sup>.

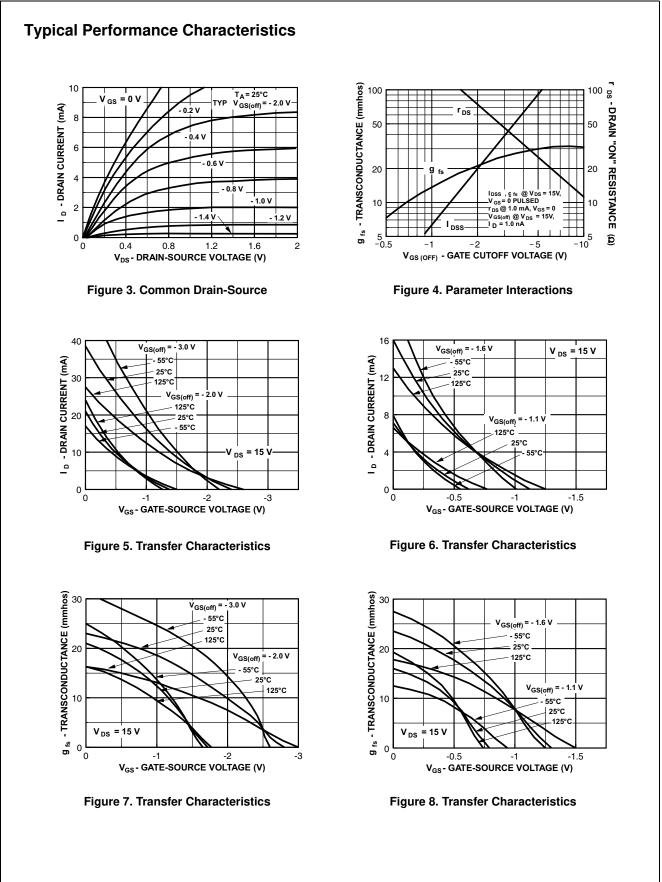
# **Electrical Characteristics**

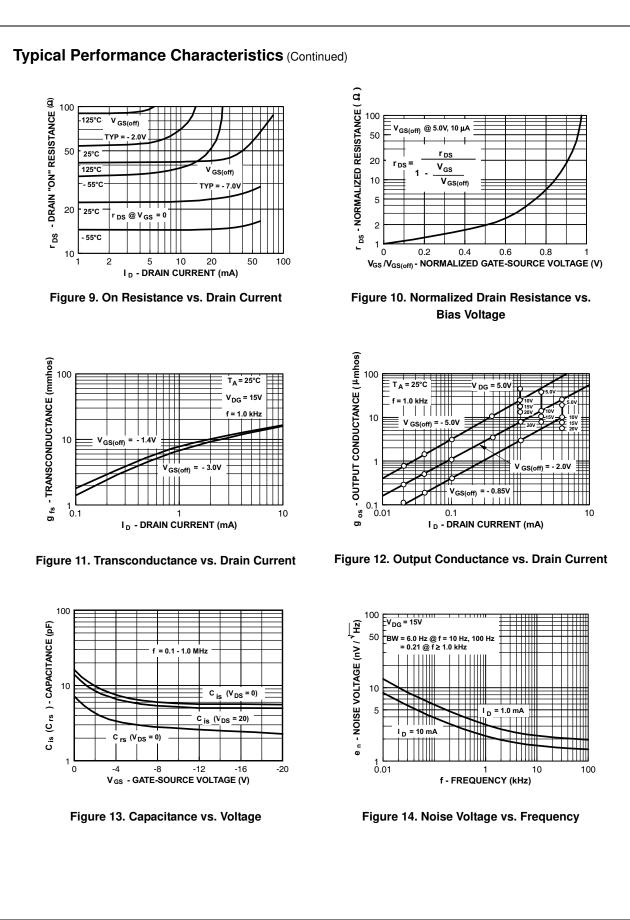
Values are at  $T_A = 25^{\circ}C$  unless otherwise noted.

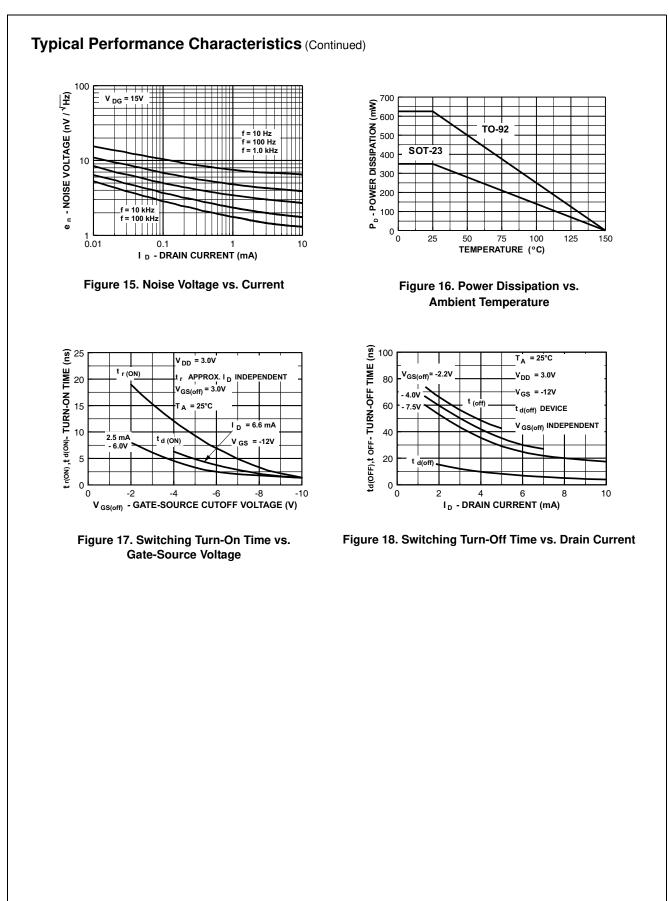
| Symbol                                       | Parameter Conditions                           |   |     | Min. | Max.  | Unit |
|--|--|---|-----|------|-------|------|
| Off Charac                                   | teristics                                      |   |     |      |       |      |
| V <sub>(BR)GSS</sub>                         | Gate-Source Breakdown Voltage                  | $I_G = -1.0 \ \mu A, \ V_{DS} = 0$                        |     | -35  |       | V    |
| I <sub>GSS</sub>                             | Gate Reverse Current                           | V <sub>GS</sub> = -15 V, V <sub>DS</sub> = 0              |     |      | -1.0  | nA   |
| V <sub>GS</sub> (off)                        | Gate-Source Cut-Off Voltage                    | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 1.0 μA           | 111 | -3.0 | -10.0 | v    |
|  |  |   | 112 | -1.0 | -5.0  |      |
|  |  |   | 113 | -0.5 | -3.0  |      |
| I <sub>D</sub> (off)                         | Drain Cutoff Leakage Current                   | V <sub>DS</sub> = 5.0 V, V <sub>GS</sub> = -10 V          |     |      | 1.0   | nA   |
| On Charac                                    | teristics                                      |   |     |      |       | •    |
| I <sub>DSS</sub>                             | Zero-Gate Voltage Drain Current <sup>(5)</sup> | $V_{DS} = 15 \text{ V}, V_{GS} = 0$                       | 111 | 20   |       | mA   |
|  |  |   | 112 | 5.0  |       |      |
|  |  |   | 113 | 2.0  |       |      |
| r <sub>DS</sub> (on)                         | Drain-Source On Resistance                     | $V_{DS} \le 0.1 \text{ V}, V_{GS} = 0$ 11                 | 111 |      | 30    |      |
|  |  |   | 112 |      | 50    |      |
|  |  |   | 113 |      | 100   |      |
| Small Sigr                                   | al Characteristics                             |   |     |      | •     |      |
| C <sub>dg</sub> (on)<br>C <sub>sg</sub> (on) | Drain-Gate &Source-Gate On<br>Capacitance      | $V_{DS} = 0, V_{GS} = 0, f = 1.0 \text{ MHz}$             |     |      | 28    | pF   |
| C <sub>dg</sub> (off)                        | Drain-Gate Off Capacitance                     | V <sub>DS</sub> = 0, V <sub>GS</sub> = -10 V, f = 1.0 MHz |     |      | 5.0   | pF   |
| C <sub>sg</sub> (off)                        | Source-Gate Off Capacitance                    | V <sub>DS</sub> = 0, V <sub>GS</sub> = -10 V, f = 1.0 MHz |     | 5.0  | pF    |      |

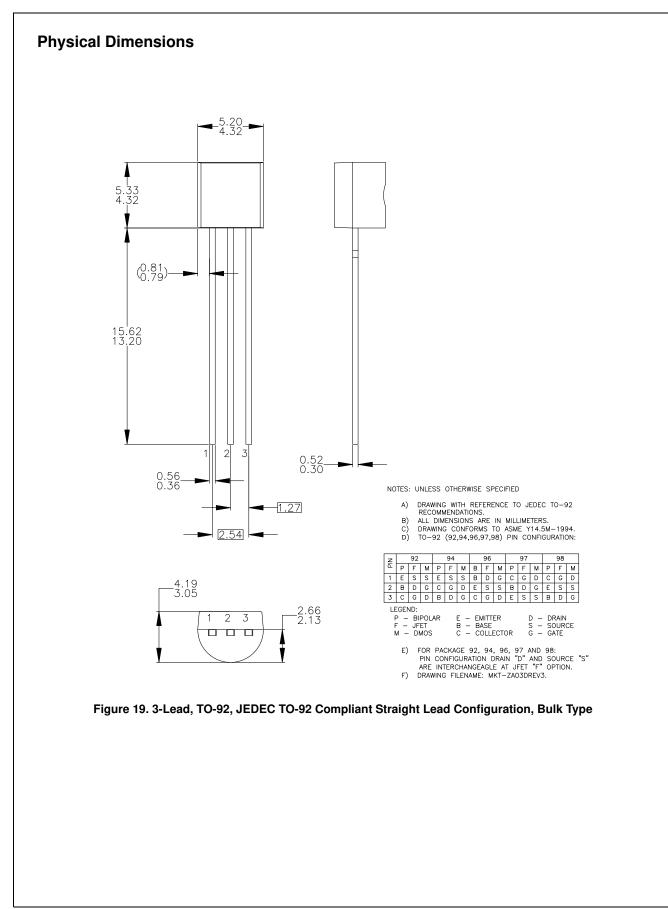
### Note:

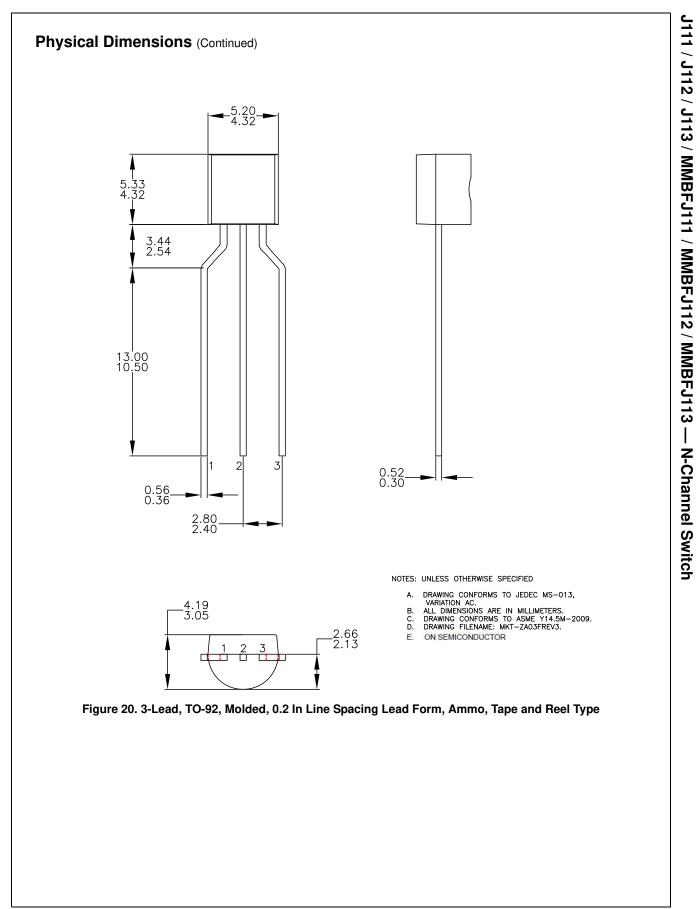
5. Pulse test: pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2%.

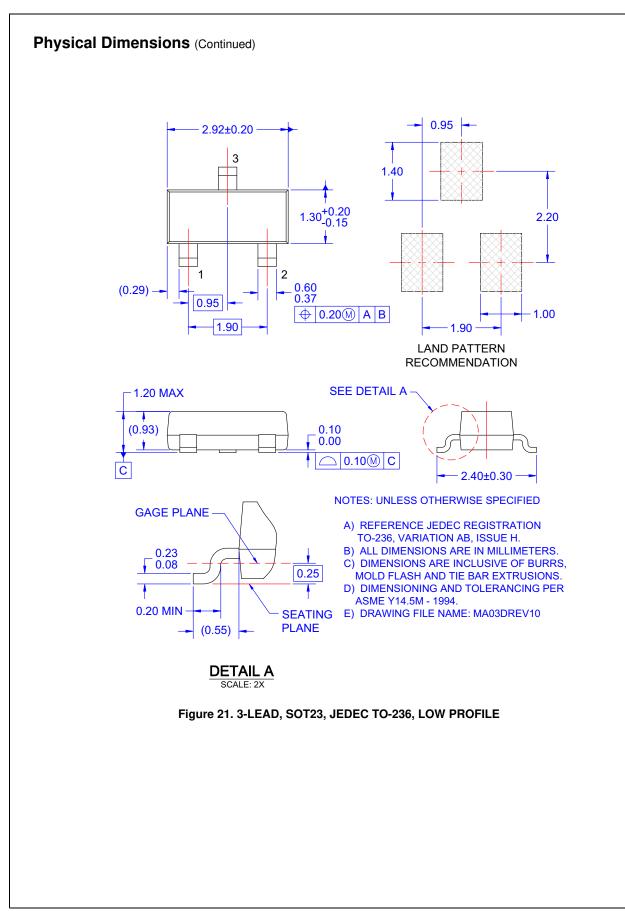












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